



## INFORMATION DISCLOSURE STATEMENT

Applicant : Sampsell et al.  
App. No : 10/731,989  
Filed : December 9, 2003  
For : AREA ARRAY MODULATION AND  
LEAD REDUCTION IN  
INTERFEROMETRIC MODULATORS  
Examiner : Choi, William C.  
Art Unit : 2873

## CERTIFICATE OF MAILING

I hereby certify that this correspondence and all marked attachments are being deposited with the United States Postal Service as first-class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on

March 31, 2005  
(Date)

Mr. Abumeri  
Mark M. Abumeri, Reg. No. 43,458

Mail Stop Amendment  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

Enclosed for filing in the above-identified application is an Information Disclosure Statement by Applicant (PTO/SB/08 equivalent) listing 32 references to be considered by the Examiner, including 9 foreign patent references as listed on the Information Disclosure Statement. Hardcopies of the 9 foreign patent references are enclosed herewith.

This Information Disclosure Statement is being filed before the receipt of a first Office Action on the merits, and presumably no fee is required. If a first Office Action on the merits was mailed before the mailing date of this Statement, the Commissioner is authorized to charge the fee set forth in 37 C.F.R. § 1.17(p) to Deposit Account No. 11-1410.

Respectfully submitted,

KNOBBE, MARTENS, OLSON & BEAR, LLP

Dated: March 31, 2005

By: Mr. Abumeri  
Mark M. Abumeri  
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# INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Multiple sheets used when necessary)

SHEET 1 OF 2

Application No.	10/731,989
Filing Date	December 9, 2003
First Named Inventor	Sampsell, Jeffrey Brian
Art Unit	2873
Examiner	Choi, William C.
Attorney Docket No.	IRDM.129A

## U.S. PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	1	5,835,255	11.10.1998	Miles	
	2	5,986,796	11.16.1999	Miles	
	3	6,040,937	03.21.2000	Miles	
	4	6,055,090	04.25.2000	Miles	
	5	2001/0003487 A1	06.14.2001	Miles	
	6	2002/0015215 A1	02.07.2002	Miles	
	7	2002/0075555 A1	06.20.2002	Miles	
	8	2002/0126364 A1	09.12.2002	Miles	
	9	2003/0043157 A1	03.06.2003	Miles	
	10	2003/0072070 A1	04.17.2003	Miles	
	11	6,574,033 B1	06.03.2003	Chui et al.	
	12	6,589,625 B1	07.08.2003	Kothari et al.	
	13	6,650,455 B2	11.18.2003	Miles	
	14	6,674,562 B1	01.06.2004	Miles	
	15	6,680,792 B2	01.20.2004	Miles	
	16	2004/0051929 A1	03.18.2004	Sampsell et al.	
	17	6,710,908 B2	03.23.2004	Miles et al.	
	18	2004/0058532 A1	03.25.2004	Miles et al.	
	19	6,741,377 B2	05.25.2004	Miles	
	20	6,794,119 B2	09.21.2004	Miles	
	21	2004/0240032 A1	12.02.2004	Miles	
	22	2004/0263944 A1	12.30.2004	Miles et al.	
	23	6,867,896	03.15.2005	Miles	

## FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T <sup>1</sup>
	24	WO 95/30924	11-16-1995	Etalon, Inc.		
	25	WO 97/17628	05-15-1997	Etalon, Inc.		
	26	WO 99/52006 A2	10-14-1999	Etalon, Inc.		

Examiner Signature

Date Considered

\*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

T<sup>1</sup> - Place a check mark in this area when an English language Translation is attached.

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	Filing Date	December 9, 2003
	First Named Inventor	Sampsell, Jeffrey Brian
	Art Unit	2873
(Multiple sheets used when necessary)	Examiner	Choi, William C.
SHEET 2 OF 2	Attorney Docket No.	IRDM.129A

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	27	WO 99/52006 A3	10-14-1999	Etalon, Inc.		
	28	WO 03/007049 A1	01-23-2003	Iridigm Display Corp.		
	29	WO 03/069413 A1	08-21-2003	Iridigm Display Corp.		
	30	WO 03/073151 A1	09-04-2003	Iridigm Display Corp.		
	31	WO 04/006003 A1	01-15-2004	Iridigm Display Corp.		
	32	WO 04/026757 A2	04-01-2004	Iridigm Display Corp.		

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